Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/628,384	OOISHI ET AL.
Examiner	**Art Unit**
An T. Luu	2816

SEARCHED			
Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
See Attachment		4/24/2007	ATL

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST -Updated Search	4/24/2007	ATL